

OPEN ACCESS

Probing High Oxygen Activity in YSZ Electrolyte

To cite this article: Adrián Robles-Fernández *et al* 2022 *J. Electrochem. Soc.* **169** 044503

View the [article online](#) for updates and enhancements.

Investigate your battery materials under defined force!
The new PAT-Cell-Force, especially suitable for solid-state electrolytes!



- Battery test cell for force adjustment and measurement, 0 to 1500 Newton (0-5.9 MPa at 18mm electrode diameter)
- Additional monitoring of gas pressure and temperature

www.el-cell.com +49 (0) 40 79012 737 sales@el-cell.com

EL-CELL[®]
electrochemical test equipment





Probing High Oxygen Activity in YSZ Electrolyte

Adrián Robles-Fernández,¹ Alodia Orera,¹ José I. Peña,¹ and Rosa I. Merino²

¹Instituto de Nanociencia y Materiales de Aragón, CSIC—Universidad de Zaragoza, E-50009 Zaragoza, Spain

The redox behavior of terbium and praseodymium doped yttria-stabilized zirconia (YSZ) is studied. The aim is to identify spectroscopic probes and a suitable experimental procedure to monitor the oxygen activity in YSZ electrolytes in solid oxide cells with spatial resolution and at operation conditions (e.g. at high temperatures). Sintered ceramics and crystals with 0.3 to 10 at% content of Pr or Tb ions in YSZ were prepared. Upon equilibration in atmospheres from 10^{-20} to 100 bar P_{O_2} around 800 °C, the majority of these rare earth ions are in the 3+ oxidation state. At oxygen pressures above 0.001 bar, the small proportion of Tb^{4+} and Pr^{4+} formed give rise to intense optical absorption around 300–500 nm and to decreased reflectance. From the reflectance measurements it is shown that the Tb^{4+} concentration increases as $P_{O_2}^{1/4}$, as correspond to the trapping of the holes generated upon the oxygen incorporation as Tb^{4+} . This competitive absorption causes a decrease of the Tb^{3+} luminescence. A quantitative relationship of the Tb^{3+} luminescence intensity with P_{O_2} at 800 °C has been found, which is compatible with the trapping model. The spatial resolution of the experimental procedure could be very roughly estimated of the order of 100 μm .

© 2022 The Author(s). Published on behalf of The Electrochemical Society by IOP Publishing Limited. This is an open access article distributed under the terms of the Creative Commons Attribution Non-Commercial No Derivatives 4.0 License (CC BY-NC-ND, <http://creativecommons.org/licenses/by-nc-nd/4.0/>), which permits non-commercial reuse, distribution, and reproduction in any medium, provided the original work is not changed in any way and is properly cited. For permission for commercial reuse, please email: permissions@iopublishing.org. [DOI: 10.1149/1945-7111/ac60f2]



Manuscript submitted December 20, 2021; revised manuscript received March 3, 2022. Published April 4, 2022.

Supplementary material for this article is available [online](#)

Yttria stabilized zirconia (YSZ) is the state of the art electrolyte in solid oxide fuel cells and electrolyzers as well as an archetypal oxide electrolyte.^{1,2} These devices are considered today one of the technologies that will contribute sensibly to reach a carbon-neutral economy in the near future. With respect to their optimization, there are still degradation issues that need to be harnessed.^{3,4} One of the degradation processes that leads to the cracking of the electrolyte and/or delamination of the electrolyte–oxygen electrode interface, are known to be the very high oxygen activity and/or large gradients in regions of the electrolyte near to the oxygen electrode.^{5,6,7–9} Red-ox dopants in the electrolyte can help to investigate these activity gradients.

Small concentration of red-ox dopants in YSZ (of the order of 100 ppm), such as titanium or cerium, strongly depress the oxygen chemical diffusion coefficient. These dopants trap the minority carriers, electrons or holes, and delay the establishment of the new steady-state oxygen activity profile inside the electrolyte upon a change in the surrounding oxygen activity.^{10–13} However, very low dopant concentrations do not change the concentration of free minority carriers or its conductivity at equilibrium.¹¹ Sasaki and Maier performed a systematic study to determine the equilibrium concentration in different oxidation states of Ce and several 3d ions by monitoring in situ the optical absorption in YSZ single crystals or the EPR signals specific of one or both of the redox states of the dopant.¹⁴ From this excellent work they provided expressions for the relative concentration of oxidized or reduced dopant vs the oxygen partial pressure (P_{O_2}). At 800 °C, the P_{O_2} at which there are similar amounts of both oxidation states in YSZ goes from 10^{-24} bar for Ti^{3+}/Ti^{4+} to 3×10^{-2} bar for Mn^{2+}/Mn^{3+} . This value determines the oxygen activity range which each dopant can monitor.

In order to achieve spatial resolution to the oxygen activity monitoring in electrolytes, optical signals that can be detected through microscope objectives in backscattering geometry should be selected. For example, micro-spectroscopy involving electronic Raman scattering of Ce^{3+} in doped scandia stabilized zirconia, ScSZ,¹⁵ or Raman of gadolinium doped ceria, GDC,¹⁶ have been used to investigate degradation and oxygen activity in cross-sections of polarized cells. On the other hand, in-operando or in situ monitoring requires suitable probes for high temperature measurements. Raman spectroscopy has been used to analyze in situ interfacial and electrode processes in solid oxide fuel cells

(SOFCs), as well as oxygen activity or stress in different layers of the cell,^{17–21} by monitoring the Raman spectra of GDC in the electrolyte or the composite electrode. Specifically designed cells and systems were used by these authors to have optical access to the electrodes or to the region near the electrode-electrolyte interface. To allow optical access inside the electrolyte, cells built with YSZ single crystals as electrolytes could be used, with access through holes in the electrodes (working or counter electrode) or designing geometries with lateral optical access and meaningful polarization strategies. In addition to Raman, red-ox active luminescent probes, with sharp bands and small thermal quenching would also be appropriate, as luminescence usually produces more intense signals than Raman scattering. In this sense, most of rare earth ions dissolved in transparent oxides show sharp and rather intense luminescence bands, and some of them also persist up to high temperatures. In fact, Tb^{3+} or Eu^{3+} doped oxides have been evaluated as luminescence thermometers for high temperature applications.^{22,23} In particular, 4f ions are also easily introduced into the fluorite lattice of yttria stabilized zirconia (YSZ).^{24,25}

Among the ions of the 4f group, those with the larger redox activity are Ce, Pr and Tb^{2+} and, in fact, solid solutions of ZrO_2 with these rare earth oxides are being studied as oxygen storage compounds or for catalysis applications.²⁷ Cerium reduces to Ce^{3+} when the oxygen activity is low, having equal concentrations of Ce^{3+} and Ce^{4+} in YSZ at around $P_{O_2} = 3 \times 10^{-14}$ bar (at 800 °C).¹⁴ Ce^{3+} is optically active with an intense optical absorption band and electronic Raman activity,¹⁰ but does not produce luminescence. The Ce^{3+} electronic Raman signal is no longer detectable at temperatures above approximately 300 °C, as proven in the course of this investigation. Pr and Tb are mainly in the 3+ oxidation state as dopants in YSZ, and show rich luminescence spectra.^{28,29–32} Specifically, luminescence arising from radiative deexcitation of the 1D_2 (Pr^{3+}) and 5D_4 (Tb^{3+}) levels are intense. These levels are separated by about 7000 cm^{-1} and 15000 cm^{-1} from the next lower level, and therefore the thermal quenching of their luminescence is expected to be weak, as observed,²² so that they could be useful as in situ probes.

The present work aims to study the changes in the optical spectra (absorption, reflectance and luminescence) of Pr or Tb doped YSZ upon different atmospheres. Ultimately, we seek to find the relationship between an appropriate luminescence signal and the oxygen activity inside the material, specifically in the relatively high oxygen partial pressure range, so that they could serve to monitor oxygen activity in the YSZ electrolyte near to the oxygen electrode.

²E-mail: r.merino@csic.es, rmerino@unizar.es

Experimental

We have sintered samples with different concentrations of the dopants and solidified crystals of Tb doped YSZ to serve this study. Polycrystalline ceramic samples were prepared using solid state synthesis. Commercial powders of 8 mol% yttria-stabilized zirconia (TZ-8YS, Tosoh Corp.) were weighed and mixed with Pr₆O₁₁ (99.9% Sigma Aldrich) or Tb₄O₇ (99.99% Thermo-Fischer Scientific) to obtain the desired dopant content. Sample acronyms and nominal compositions are given in Table I. Content of Hf and Y was analyzed for pristine TZ-8YS powder by X-ray fluorescence (THERMO ELECTRON, ARL series, model ADVANT^{XP} and the software UNIQUANT for semi-quantitative analysis).

The oxide mixture was mixed thoroughly with mortar and pestle. To prepare 1 gram of product, 5 drops of a 5 wt% polyvinyl alcohol (99+% Sigma Aldrich) solution in water were added to the powders to act as a binder. Cylindrical pellets of the powders were uniaxially pressed in a 13 mm diameter die applying 5 Tons for 5 min. The pellets were sintered at 1500 °C for 10 h, yielding fully dense pellets.

Single crystals were solidified using the laser floating zone method.³³ Feedstock rods with compositions YSZ-0.3Tb, YSZ-1Tb and YSZ-5Tb, approximately 2 mm in diameter, were prepared by isostatic cold pressing and sintering. The crystal was solidified pulling downwards at 50 mm h⁻¹. After solidification the crystals were annealed in air at 1600 °C and cooled slowly (3 °C min⁻¹) to relieve stresses. Analysis of the Tb content of the YSZ-1Tb solidified crystal was done by EDS (energy dispersive X-ray spectroscopy) in a field emission scanning electron microscope (FESEM, model Carl Zeiss MERLIN), using the equipment library of standards for quantification. This gave a Tb concentration of 1.03 at% Tb, standard deviation 0.07, in agreement with the nominal doping content.

Sets of both polycrystalline and single crystal samples were annealed at 900 °C for 2 h in different atmospheres and cooled to room temperature as fast as possible. Annealing conditions for equilibrium were previously determined by measuring diffuse reflectance of various samples with different annealing times, showing that 2 h long treatments are sufficient at 900 °C, while annealing at 800 °C needed 24 h dwelling times. Regarding the annealing media, flowing 5% H₂-Ar, Argon, air or O₂ at atmospheric pressure were used for anneals at P_{O₂} up to 1 bar. The oxygen partial pressure was measured with a zirconia lambda probe for the treatments in flowing Ar and 5%H₂-Ar at 800 °C. Pure static O₂ in a pressurized chamber was used for anneals above atmospheric pressure. High pressure treatments were followed by free furnace cooling. When referring to samples annealed in the different media, -Air, -Ar or -H₂ will be appended to the acronym listed in Table I.

Total hemispherical diffuse reflectance and optical absorbance measurements were carried out using a Cary 5000 UV-vis-NIR spectrometer (Agilent Technologies, Inc., USA). Most of the reflectance experiments were performed with a 110 mm diameter integrating sphere DRA-2500 (Agilent Technologies, Inc., USA). Unless otherwise stated, an 8 mm diameter diaphragm on the

reflectance port to hold the sample and a Halon plate as reflectance standard. The reflectance spectra of the YSZ-5Pr sample was measured using a Praying Mantis accessory, and pressed BaSO₄ as reference standard. For reflectance characterization, the pellets were ground with CarbiMet SiC P320 grinding paper (Buehler) in order to assure an equal finish of the pellet surfaces. For optical absorption, crystal pieces were lapped and polished with diamond paste on both faces to get plane-parallel longitudinal slices around 1 mm thick.

Luminescence measurements were carried out using an excitation wavelength $\lambda = 488.0$ nm from an Ar⁺ laser source (INNOVA 200, Coherent, Palo Alto, CA, USZ) or a krypton-argon laser (Melles Griot, Carlsbad, CA, USA), with backscattering geometry. An optical microprobe spectrometer (Model XY, Dilor, France), equipped with a CCD detector and an Olympus BH-2 microscope, and a x50 long working distance (0.55 NA) microscope objective were used. Excitation output power were around 150 mW and less than 10 mW for YSZ-Pr and YSZ-Tb samples respectively, to avoid saturation of the CCD detector. The reported luminescence spectra are the average of at least 10 measurements on each sample. Raman spectra were measured with the same equipment, using appropriate laser lines for excitation.

The structure of the sintered and solidified samples was characterized by Raman spectroscopy. The spectra of the samples, ceramics and crystals, are given in the supplementary information, Fig. SII (available online at stacks.iop.org/JES/169/044503/mmedia). They show the typical spectra of cubic or t' zirconia.³⁴ As expected, the Raman shift of the O-Zr stretching mode (around 620 cm⁻¹) moves towards lower energies as the dopant content increases, supporting the formation of a solid solution.³⁵

Results

Evolution of the optical absorption upon red-ox treatments.—

Reflectance spectra of Pr doped samples are given in Fig. 1a. In the SI (supplementary information), Fig. SI2, the spectra for 0.3% Pr and 5%Pr doped pellets are given. The spectra show a high reflectance background at long wavelengths with the corresponding absorption bands due to Pr³⁺ ions. These are intraconfigurational transitions from the ground state multiplet (³H₄) level to excited levels within the 4f² electronic configuration, and are clearly seen as valleys in the spectra. Broad and intense absorptions in the region from 2400 nm to 1200 nm correspond to transitions to multiplets ³H₆, ³F₂, ³F₃ and ³F₄. The band around 1000 nm corresponds to the transition to ¹G₄. The bands from 600 to 550 nm correspond to the transition to ¹D₂ and the ones with maxima from 487 nm to 450 nm to the transitions to ³P₀, ³P₁, ³P₂.^{30,36}

At short wavelengths the reflectance diminishes as the oxygen partial pressure increases, due to absorption. The sample annealed in air shows a broad absorption around 500 nm, which can be more clearly distinguished as the dopant concentration increases (see Figs. 1b, or SI2). Therefore, it is reasonable to associate this band to absorptions involving oxidized dopant species, such as interconfigurational Pr⁴⁺ transitions or charge transfer bands (from occupied O⁼ orbitals to unoccupied Pr⁴⁺ orbitals), both of which are expected

Table I. List of acronyms and nominal compositions of the samples used in this work.

| Acronym | Dopant content (cation basis) | Nominal composition |
|-----------|-------------------------------|---|
| YSZ-0.3Tb | 0.3 at% | (Zr _{0.843} Y _{0.1484} Hf _{0.0082}) _{0.997} Tb _{0.003} O _{2-δ} |
| YSZ-1Tb | 1 at% | (Zr _{0.843} Y _{0.1484} Hf _{0.0082}) _{0.99} Tb _{0.01} O _{2-δ} |
| YSZ-3Tb | 3 at% | (Zr _{0.843} Y _{0.1484} Hf _{0.0082}) _{0.97} Tb _{0.03} O _{2-δ} |
| YSZ-5Tb | 5 at% | (Zr _{0.843} Y _{0.1484} Hf _{0.0082}) _{0.95} Tb _{0.05} O _{2-δ} |
| YSZ-10Tb | 10 at% | (Zr _{0.843} Y _{0.1484} Hf _{0.0082}) _{0.9} Tb _{0.1} O _{2-δ} |
| YSZ-0.3Pr | 0.3 at% | (Zr _{0.843} Y _{0.1484} Hf _{0.0082}) _{0.997} Pr _{0.003} O _{2-δ} |
| YSZ-1Pr | 1 at% | (Zr _{0.843} Y _{0.1484} Hf _{0.0082}) _{0.99} Pr _{0.01} O _{2-δ} |
| YSZ-5Pr | 5.24 at% | (Zr _{0.843} Y _{0.1484} Hf _{0.0082}) _{0.9476} Pr _{0.0524} O _{2-δ} |

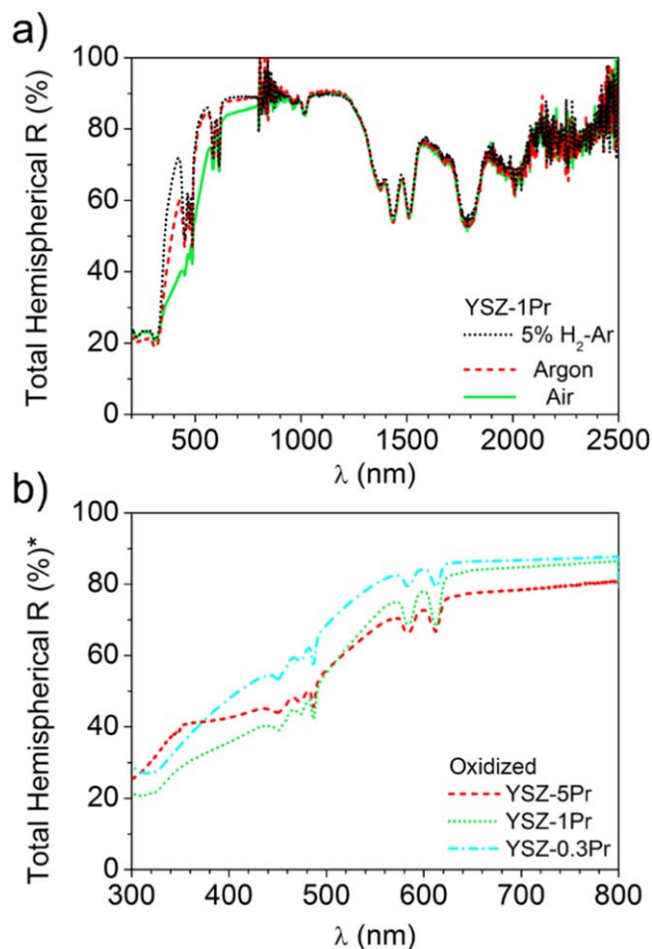


Figure 1. (a) Total hemispherical reflectance of YSZ sintered pellets doped with 1%Pr (cation basis, nominal concentration). Different curves show the measurement on samples annealed at 900 °C in different atmospheres (5%H₂-Ar (black, dotted line), Ar (red, dashed line), air (green, continuous line)). (b) Total hemispherical reflectance of YSZ sintered pellets doped with 0.3% (cyan, dash-dot line), 1% (green, dotted line) or 5% Pr (red, dashed line) (concentrations in cation basis, nominal concentration), annealed in air at 900 °C for 2 h (0.3% and 1% Pr) or in O₂ at 600 °C for 48 h (5% Pr). (*) The measurement on the 5% Pr sample was made with the Praying Mantis accessory. For qualitative comparison with the other curves in the plot, this reflectance spectrum was multiplied by an arbitrary factor.

to have large optical activity (strong absorption). Hoefdraad³⁷ assigns similar absorption bands in oxides with 8-coordinated Pr⁴⁺ to charge transfer bands, which would appear at lower energies than interconfigurational transitions.

As in the Pr doped samples, the reflectance spectra of Tb doped pellets (Figs. 2a and 2b) show a high reflectance background with strong absorption in the UV absorption edge. In the SI, Fig. SI3, the spectra for the same samples annealed in argon and 5% H₂-Ar are given, while Fig. SI4 gives the spectra for the sample YSZ-5Tb. In the near infrared (NIR) region, absorption bands (valleys) due to Tb³⁺ ions transitions within the 4f⁸ electronic configuration are clearly seen. These are absorptions due to transitions from ⁷F₆ to levels ⁷F₀, ⁷F₁ or ⁷F₂ multiplets.^{38,39} Much weaker are the Tb³⁺ absorption bands in the visible region,⁴⁰ which are hard to distinguish in Fig. 2. Figure 3 shows the optical absorption spectra of 1at% Tb doped single crystals, in the VIS-UV range. Small absorption bands corresponding to excitations to the ⁵D₄ level at 487 nm and to the ⁵D₃ at 380 nm can be seen in the inset. It shows the absorption of the sample annealed in 5% H₂-Ar from 360 to 500 nm. Another broad absorption band in this region of the spectrum, with maximum at around 360 nm (3.45 eV) and full

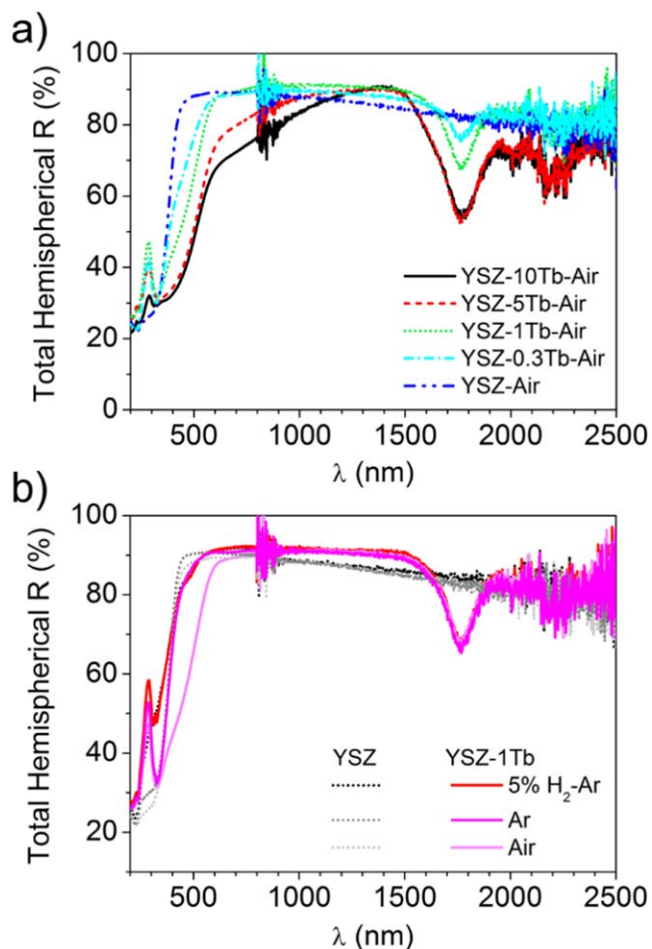


Figure 2. (a) Total hemispherical reflectance of YSZ sintered pellets, undoped and doped with Tb and annealed in air at 900 °C for 2 h, followed by quenching: undoped (blue, dash-dot-dot line), YSZ-0.3Tb (cyan, dash-dot line), YSZ-1Tb (green, dotted line), YSZ-5Tb (red, dashed line) and YSZ-10Tb (black, continuous line). (b) Total hemispherical reflectance of YSZ (dotted lines) and YSZ-1Tb (continuous lines) sintered pellets, annealed in different atmospheres at 900 °C for 2 h. In air: light grey and light pink; in Ar: grey and magenta; in Ar-5%H₂: red and black lines.

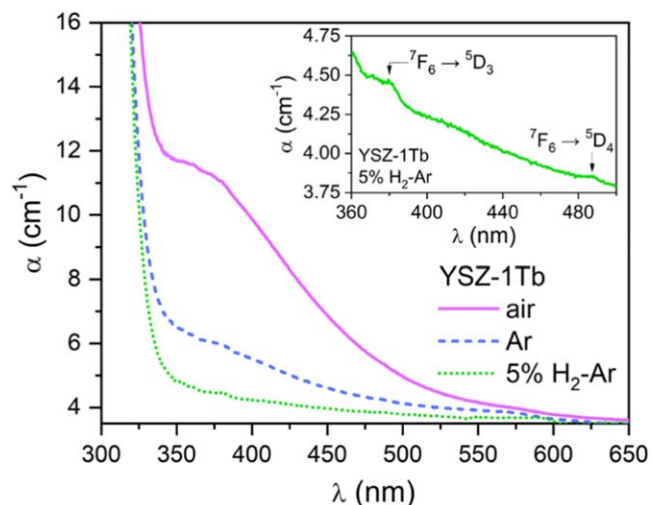


Figure 3. Optical absorption spectrum of YSZ-1Tb single crystals annealed in different atmospheres at 900 °C for 2 h. Dotted line: YSZ-1Tb-H₂; dashed line: YSZ-1Tb-Ar and continuous line: YSZ-1Tb-air. On the inset, detail of the peaks corresponding to Tb³⁺ absorptions in the YSZ-1Tb-H₂ crystal.

with at half maximum (FWHM) around 1.2 eV, is evident in the absorption spectra of the crystal annealed in air. This absorption band together with the specific scattering gives rise to the reflectance spectra as broad, diminished reflectance in the short wavelength side ($\lambda < 500$ nm), being more intense the higher the dopant concentration (see Fig. 2a) and the higher the oxygen activity of the annealing atmosphere (Fig. 2b).

Note also that the reflectance of the undoped sample decreases as wavelength increases (Fig. 2a). We can attribute this behavior to the smaller scattering as wavelength increases expected for well-sintered YSZ. This leads to a fraction of the incident light intensity escaping the experiment (either as forward transmittance or through the sample edges). As the dopant content increases, this tendency is less evident (see also Fig. S13 in SI, for reflectance spectra of the samples annealed in 5% H₂-Ar).

The reflectance spectra for highly doped, oxidized samples show also a large absorption tail extending from the VIS up to 1200 nm, caused either by the large width of the optical absorption band or by other, less intense and broad absorptions extending towards lower energies. The optical absorption measured on a nominally 5 at% Tb doped crystal is proportional to the one shown in Fig. 3 with appropriate scaling for concentration and scattering and/or reflectance at the crystal surfaces. The spectra are shown in SI (Fig. S15). It is clear that this absorption is due to oxidized species related to the Tb dopant, that on the same grounds than in Pr doped zirconia, can be assigned to charge transfer (from occupied O⁼ orbitals to unoccupied Tb⁴⁺ orbitals). Broad band assigned to Tb⁴⁺ CT transitions have been reported by van Vugt et al. in ZrO₂,⁴¹ Hoefdraad in ThO₂ and other oxides,³⁷ Verma et al. in MO-Al₂O₃ phosphors⁴² or E. Zych et al. in Lu₂O₃ scintillators.⁴³

Finally, note in Figs. 2b and S14 (reflectance spectra), as well as in absorption (Fig. S15), that the large increase in absorption in the visible-UV range associated to the formation of oxidized species is not accompanied by a decrease in absorption of the Tb³⁺ absorption bands, for example the ones in the NIR. The same is true for the Pr doped samples (see Fig. 1), and was also observed by Savoini et al. investigating the absorption spectra of single crystals.³⁰ That is, only a very small fraction of rare earth dopant has been oxidized in the air anneals. The NIR absorption spectra of the 5% Tb doped crystal allows estimating an upper limit of 0.1% of Tb³⁺ oxidized to Tb⁴⁺ upon annealing in air at 900 °C.

Luminescence.—The observed luminescence spectra of the YSZ doped samples annealed in air, Ar or 5% H₂-Ar flows correspond to luminescence of the dopants in the 3+ oxidation state. The luminescence spectra of Pr³⁺ and Tb³⁺ ions in YSZ have been previously reported.^{28,30,32} Here we are interested in the most intense luminescence bands in the VIS from levels with small thermal quenching. Excitation with the 488 nm Ar⁺ laser line is resonant with the ³H₄ → ³P₀ and ⁷F₆ → ⁵D₄ absorptions of Pr³⁺ or Tb³⁺ respectively, and produces luminescence bands in the visible region. In YSZ:Pr³⁺, the most intense band appears around 615 nm arising from radiative deexcitation of the ¹D₂ level to the ground state (³H₄ multiplet). In YSZ:Tb³⁺ the strongest luminescence is the one

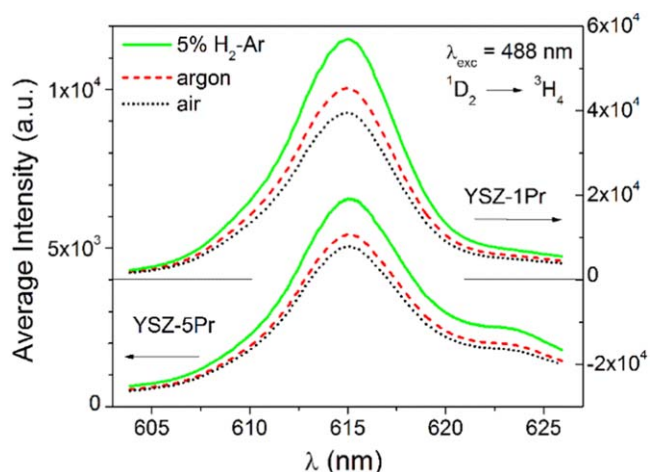


Figure 4. Luminescence spectra corresponding to the transition ¹D₂ to ³H₄, excited with $\lambda = 488$ nm (Ar + laser line), measured at room temperature on Pr doped YSZ pellets previously annealed at 900 °C in different atmospheres. Upper plots and right-hand side scale: YSZ-1Pr; lower plots and left-hand side scale: YSZ-5Pr. Treatments in 5% H₂-Ar (dotted black lines), Ar (dashed red lines) and air (continuous green lines).

around 550 nm, produced by radiative deexcitation of the ⁵D₄ level to the first excited multiplet (⁷F₅).

The spectra of samples with 1 at% and 5 at% doping of the respective ions, and annealed in the different atmospheres at 900 °C are given in Fig. 4 (YSZ-xPr) and Fig. 5 (YSZ-xTb). Quantitative details are collected in Table II. For both dopants, the samples annealed in reducing atmosphere show the strongest luminescence. The intensity ratio of each sample vs its value in the reduced sample is also given in Table II. This ratio changes consistently (above the uncertainty of the measurement) and is smaller in the samples with 5 at% Tb. Note for example that the measured luminescence in the samples doped with 5 at% Tb annealed in air are around 1/3 of the one measured for the samples annealed in H₂. For 1 at% Tb or Pr doped samples the ratio is around 0.7 to 0.8.

The dependence of the average peak intensity with concentration is different for each dopant (Table III). On the one side, YSZ-5Pr samples show smaller luminescence intensity than YSZ-1Pr, as well as a change in the shape of the spectra. Savoini et al.³⁰ observed a faster decay monitoring the ¹D₂ to ³H₄ luminescence in YSZ doped with 6.3 at% Pr, ascribed to concentration quenching by cross-relaxation,⁴⁴ which explains the strong decrease of the luminescence intensity, as also recently observed by Wang et al.⁴⁵ for YSZ doped with Pr at concentrations above 1 at% Pr. This luminescence band also overlaps the rather intense low energy feature of the absorption corresponding to the transition ³H₄ to ¹D₂.⁴⁶

We did not use confocal diaphragm to register the luminescence, so that light emitted at planes below the surface comes inside the spectrograph and CCD detector. The attenuation of the emitted light by self-absorption can contribute to the change of the luminescence

Table II. Average Intensity (I, arbitrary units) at the maximum of the spectra plotted in Figs. 4 and 5, standard deviation (σ_d) and their ratio (3th and 6th columns).

| Sample | I at 543.6 nm (σ_d)-Tb | Ratio I vs H ₂ (σ_d)-Tb | Sample | I at 615 nm (σ_d)-Pr | Ratio I vs H ₂ (σ_d)-Pr |
|------------------------|---------------------------------|---|------------------------|-------------------------------|---|
| YSZ-1Tb-H ₂ | 24025 (930) | — | YSZ-1Pr-H ₂ | 56901 (4966) | — |
| YSZ-1Tb-Ar | 23664 (1206) | 0.98 (0.06) | YSZ-1Pr-Ar | 45418 (4545) | 0.80 (0.11) |
| YSZ-1Tb-Air | 16891 (375) | 0.70 (0.03) | YSZ-1Pr-Air | 39506 (3308) | 0.69 (0.08) |
| YSZ-5Tb-H ₂ | 96787 (6992) | — | YSZ-5Pr-H ₂ | 6542 (603) | — |
| YSZ-5Tb-Ar | 68670 (2445) | 0.71 (0.06) | YSZ-5Pr-Ar | 5434 (867) | 0.83 (0.15) |
| YSZ-5Tb-Air | 31874 (1639) | 0.33 (0.03) | YSZ-5Pr-Air | 5052 (398) | 0.77 (0.09) |

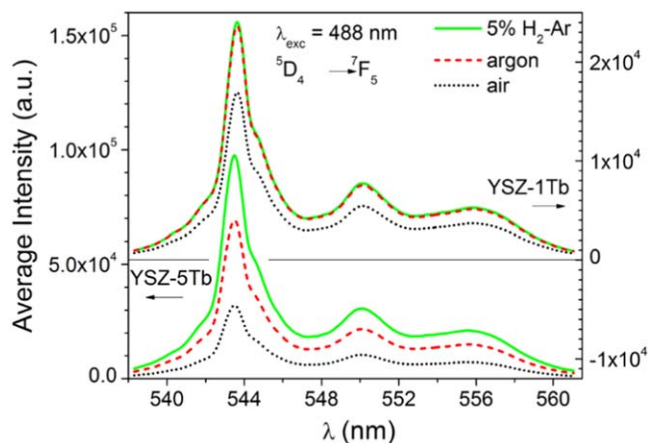


Figure 5. Luminescence spectra corresponding to the transition 5D_4 to 7F_5 , excited with $\lambda = 488$ nm (Ar^+ laser line), measured at room temperature on Tb doped YSZ pellets previously annealed at 900°C in different atmospheres. Upper plots and right-hand side scale: YSZ-1Tb; lower plots and left-hand side scale: YSZ-5Tb. Treatments in 5% H_2 -Ar (dotted black lines), Ar (dashed red lines) and air (continuous green lines).

band profile of sample YSZ-5Pr with respect to the one of YSZ-1Pr. In addition, other luminescence lines from deexcitation of the 3P_0 to the 3H_6 multiplets might become apparent as the intensity of the 1D_2 to 3H_4 luminescence decreases by cross-relaxation, and thus change the shape of the spectrum. Note that this luminescence intensity ratio is only slightly dependent on the thermochemical treatment, compatible with processes related to Pr^{3+} to be the responsible ones for the change in intensity.

In the Tb doped samples there is a very slight broadening of the spectra and a shifting of the maximum towards higher energies (by 4 cm^{-1} approx.) with the increase in the Tb concentration. There is also a more intense luminescence as the Tb concentration increases. This is clearly seen in Fig. 6, where the intensity values at maximum have been plotted with respect to the Tb dopant concentration. This luminescence is not expected to be strongly affected by concentration quenching.^{47,48} The dependence is sublinear, that is, the measured luminescence intensity increases slower than the Tb concentration.

Discussion

For the purpose of monitoring oxygen activity in YSZ, the results presented in the previous sections show that both dopants, Tb and Pr, show red-ox activity with clearly observed reflectance variations in the blue to green region of the spectra (350 to 500 nm), for cation dopant concentrations above around 1%. The maximum variation of optical activity observed takes place at oxygen partial pressures above 10^{-4} bar (equivalent to flowing Ar). Both $3+$ ions also show intense luminescence peaks in the VIS, whose intensity changes consistently with the redox treatment. The luminescence measured at 615 nm of Pr^{3+} doped samples is affected by concentration quenching and self-absorption, which in practice hinders quantitation of the oxygen activity.

On excitation of YSZ:Tb at 488 nm, the ratio of the luminescence intensity in the reduced samples with respect to the oxidized ones

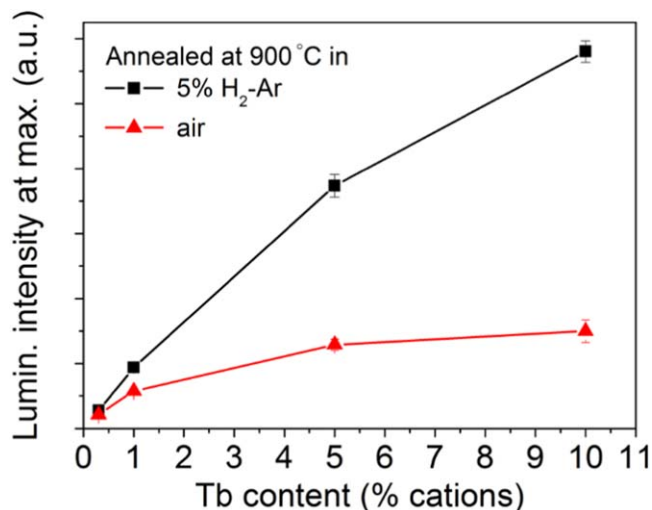


Figure 6. Intensity of the luminescence at 543.6 nm in Tb doped YSZ pellets. The error bars have a length of twice the standard deviation for 5 measurements on each sample surface. The samples have been annealed at 900°C in 5% H_2 -Ar (black squares) and in air (red triangles).

(annealed in air) is higher the higher the Tb content, according to the results shown in Fig. 6 and Tables II and III. This behavior can be easily understood as a competitive absorption of the incoming radiation at 488 nm by the Tb^{3+} ions, whose concentration remains practically unchanged upon the thermochemical treatments, and the absorption associated to (the small amount of) Tb^{4+} . As the absorption coefficient of Tb^{3+} at 488 nm is very small (see Fig. 3, inset) for YSZ-1Tb and, in samples annealed in Ar or higher oxygen partial pressure atmospheres, the attenuation of the incoming radiation is almost fully due to the absorption assigned to the O^{2-} to Tb^{4+} charge transfer band. The luminescence intensity will be an indirect measurement of this absorption. From Fig. 6 it is clear that the most sensitive measurement for up to 0.21 P_{O_2} (air) will be the one performed with YSZ-10Tb doped ceramics. For higher values of the oxygen partial pressure, lower dopant concentrations would be better in order to keep the sensitivity.

The precise, quantitative relationship between oxygen activity and luminescence intensity will be dependent on the dopant amount and the excitation and collection optical systems, including also the sample scattering as all together determine the volume of sample explored in the experiment. For this reason, it is not straightforward to establish a direct relationship between the information supplied by the reflectance measurements and the luminescence ones. In order to establish a quantitative relationship between oxygen activity and optical signal, we have chosen 3 at% Tb doped YSZ (YSZ-3Tb), 800°C annealing temperature and extended the P_{O_2} range up to 100 bar. The total hemispherical reflectance and luminescence spectra are given in Fig. 7.

Quantitative analysis of the reflectance spectra.—NIR reflectance allows a rough upper limit estimate of the proportion of Tb ions oxidized from the NIR reflectance spectra, giving that less than 1% of Tb ions were oxidized by the annealing in 100 bar O_2 .

Table III. Ratio of the Luminescence Intensity at maximum between the 5 at% doped sample and the 1 at% doped sample and their standard deviations (calculated from the data compiled in Table II).

| Sample | Ratio at 543.6 nm, Tb | σ_a | Sample | Ratio at 615 nm, Pr | σ_a |
|---------------------|--------------------------|------------|---------------------|------------------------|------------|
| YSZTb- H_2 | 4.03 | 0.33 | YSZPr- H_2 | 0.11 | 0.01 |
| YSZTb-Ar | 2.90 | 0.18 | YSZPr-Ar | 0.12 | 0.02 |
| YSZTb-Air | 1.89 | 0.11 | YSZPr-Air | 0.13 | 0.02 |

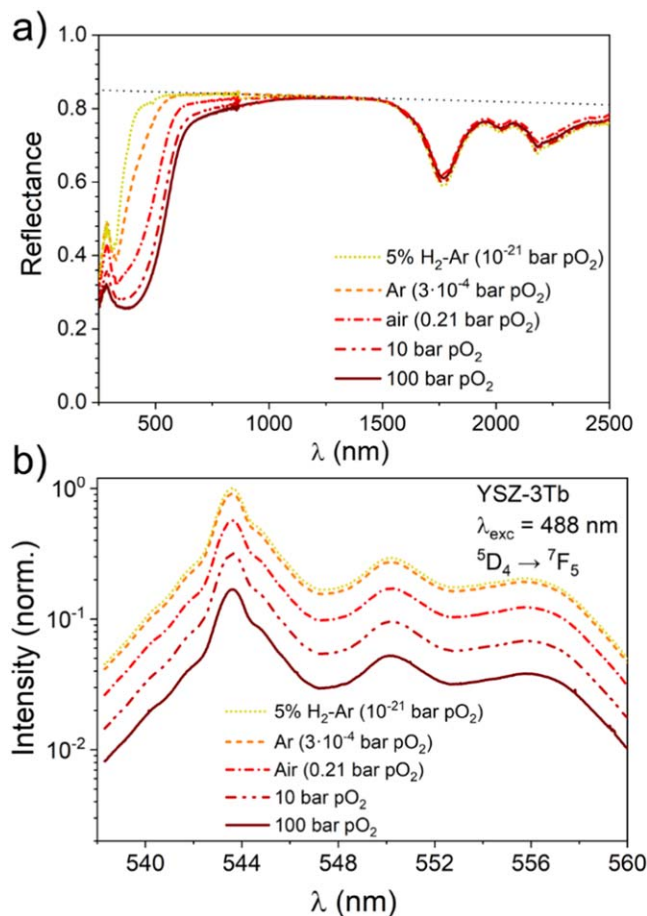


Figure 7. Hemispherical reflectance (a) and room-temperature luminescent emission spectrum of the Tb³⁺ ⁵D₄ → ⁷F₅ transition with excitation at 488 nm (b) of YSZ-3Tb samples, annealed at 800 °C for 24 h in different atmospheres. In this case a 3 mm diameter diaphragm was used on the sample at the reflectance port of the integrating sphere. A logarithmic scale is used for luminescence intensity in figure (b). The thin, black, dotted straight line in Fig. 7a is R_{white}, as explained in the text.

Therefore, a relative quantification of the Tb⁴⁺ content will be possible following the variation of the optical signals.

In the absence of light emission, the measured total hemispherical reflectance (Fig. 7) is the amount of the incident light intensity that is neither absorbed nor transmitted by the sample, that is,

$$1 = R + T + A \quad [1]$$

where R, T and A being total hemispherical reflectance, forward transmittance and absorbance. Outside the absorption bands, the forward transmittance increases with wavelength due to decreasing scattering. One can take out transmitted light from the equation (and the attenuation of the rays that end up forward transmitted) by dividing the measured reflectance by the reflectance that would be measured in a sample without absorption, that we will call R_{white}. We can estimate R_{white} with the dotted straight line plotted in Fig. 7a. R_{norm} is calculated as

$$R_{norm} = R/R_{white} \quad [2]$$

and plotted in Fig. SI5. Now, we approximate the above Eq. 1 to

$$1 = R_{norm} + A \quad [3]$$

where R_{norm} is the normalized reflectance as described, and A is the absorbance.

For small enough absorption coefficient it is reasonable to assume that the volume of sample explored in the reflectance

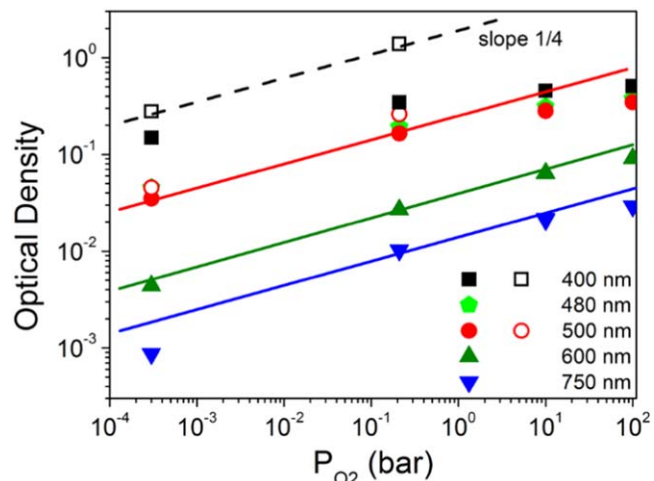


Figure 8. Estimated Optical Density for YSZ-3Tb at selected wavelengths, as a function of the annealing oxygen partial pressure. Full symbols: estimates from the reflectance of YSZ-3Tb ceramics as OD = $-\log(R_{norm})$; open symbols: estimates for a 2 mm thick crystal with 3 at% Tb, using the measured absorption coefficient values of the YSZ-5Tb single crystal. The lines, with slope 1/4, are guides to the eye.

experiment at each wavelength is determined by the microstructure (and possibly sample thickness according to the present normalization) and is independent of the absorption. Upon this assumption, from A it is possible to estimate the optical density (OD) or absorbance with

$$A = 1 - 10^{-OD} \quad [4a]$$

or

$$R_{norm} = 10^{-OD} \quad [4b]$$

OD is proportional to the absorption coefficient and the length of the light path in the material. If the length of the light path is constant, OD is a measurement of the absorption coefficient, which is the product of the molar absorption coefficient times the concentration of the optically active species. We have the measurement of the Tb⁴⁺ relative concentration.

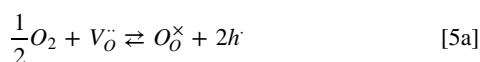
The values of the calculated OD for selected wavelengths as a function of P_{O₂} are given in Fig. 8. On the same plot, with open symbols, we give also the OD estimated for a 2 mm thick YSZ crystal doped with 3 at% Tb. These have been estimated from the OD measured for YSZ-5Tb crystals annealed at 900 °C in Ar or air (see Figs. 3 and SI5) as proportional to the respective dopant content. Note that at $\lambda = 500$ nm, both estimates coincide nicely for samples annealed in Ar (absorption coefficient ≈ 0.52 cm⁻¹) or air (absorption coefficient ≈ 3.0 cm⁻¹). This means that 2 mm is a reasonable estimate for the 500 nm light path length in the ceramics in the course of the reflectance measurement. The reasonable agreement between both estimates of absorption at 500 nm but large disagreement at 400 nm, tells also that in the latter case, the estimate of the OD from reflectance measurements as proportional to the absorption coefficient is valid up to OD values of around 0.15 (absorption coefficient of the crystal smaller than 2 cm⁻¹).

At 750 nm and 600 nm, the assumption of small absorption coefficient (α) holds. From the absorption spectra in a sample annealed in air (Figs. 3 or SI5) one can infer that it is smaller than $\alpha = 0.3$ cm⁻¹, so that, after a light path (d) of around 2 mm, OD = $0.434\alpha d$ would be below 0.03. All OD values in Fig. 8 for 600 and 750 nm are below 0.1. As indicated by the lines, this OD is approximately proportional to P_{O₂}^{1/4}. At shorter wavelengths (larger optical absorption), the proportionality of OD with P_{O₂}^{1/4} is observed for the measurements in the single crystals ($\lambda = 400$ nm or 500 nm),

or for the estimates in the ceramic samples when OD remains below around 0.15.

At large OD, for example for $\lambda = 500$ nm and very oxidized samples or for $\lambda = 400$ nm, there is a deviation of the $P_{O_2}^{1/4}$, that might be expected as the absorption coefficient cannot be so easily extracted from R_{norm} , or otherwise stated, the OD value estimated as $-\log(R_{\text{norm}})$ is no longer proportional to the absorption coefficient. The light path decreases as the optical absorption coefficient increases.

The proportionality of the absorption coefficient with $P_{O_2}^{1/4}$ is in agreement with the absorption being due to oxidized species trapping one electron hole. In YSZ, an oxide ion conductor with large concentration of oxygen vacancies, the incorporation of oxygen fills-in a small proportion of oxygen vacancies and introduces electron holes. The latter ones oxidize Tb^{3+} ions to Tb^{4+} , ultimately responsible for the observed absorption. The concentration of Tb^{4+} species depends on the P_{O_2} .⁴⁹ The equilibrium with the atmosphere through oxygen exchange



for constant concentration of oxygen vacancies and oxide ions states that

$$[h^{\bullet}] \propto (p_{O_2})^{1/4} \quad [5b]$$

Local redox equilibrium (hole trapping)



tells that

$$[Tb_{Zr}^{\times}] \propto [Tb_{Zr}^{\prime}][h^{\bullet}]. \quad [6b]$$

From Eqs. 5b and 6b it results,

$$\frac{[Tb_{Zr}^{\times}]}{[Tb_{Zr}]_0} = \frac{P_{O_2}^{1/4}}{P_0^{1/4} + P_{O_2}^{1/4}} \quad [7]$$

Where $[Tb_{Zr}]_0$ is the total concentration of Tb, and P_0 is a temperature dependent parameter that encloses the proportionality constants of Eqs. 5b and 6b. We have used Kröger-Vink notation.

In the present case where only a negligible proportion of Tb is oxidized, $\frac{[Tb_{Zr}^{\times}]}{[Tb_{Zr}]_0} \ll 1$,

$$\frac{[Tb_{Zr}^{\times}]}{[Tb_{Zr}]_0} = \left(\frac{P_{O_2}}{P_0} \right)^{1/4} \quad [8]$$

P_0 , the pressure at which the concentration of reduced and oxidized Tb species is equal, takes in this case extremely high values, higher than 10^8 bar.

Quantitative analysis of the luminescence for YSZ-3Tb.—The luminescence intensity values at the peak maximum (543.6 nm) as a function of oxygen partial pressure of thermochemical treatment are given in Fig. 9. As already argued above, the measured Tb^{3+} luminescence is excited with the amount of incident light intensity that is available after reflection at the incident sample surface and absorption by the oxidized species into the volume of sample intervening in the experiment. Therefore, only the non-absorbed light is available for excitation, or $1-A = R_{\text{norm}}$ if one would measure the back scattered reflectance in the optical configuration used to measure the luminescence. As above, R_{norm} can be written as 10^{-OD} . Let us assume that the participating volume is small enough such that it is the same at all conditions (small optical density also in the most oxidized sample). This assumption is expected reasonable for excitation and collection through a microscope objective, and it results in OD (λ_1) being proportional to the absorption coefficient

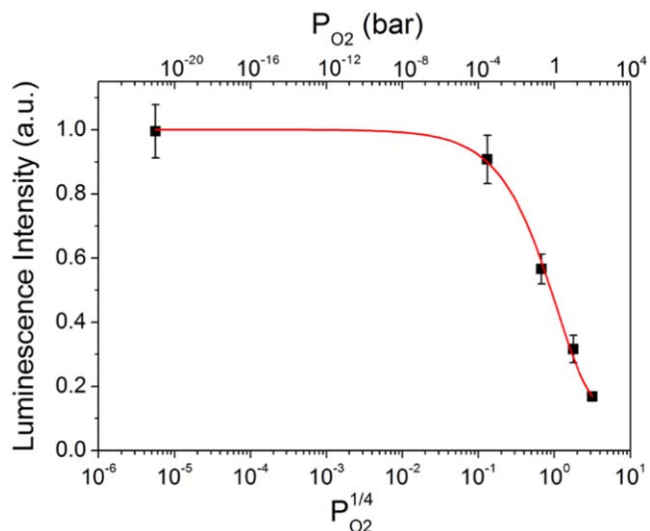


Figure 9. Luminescence intensity of YSZ-3Tb at room temperature vs the annealing $P_{O_2}^{1/4}$ at 800 °C. The continuous line is a fit to the data (see text).

and therefore to the concentration of the oxidized species, $[Tb_{Zr}^{\times}]$. λ_1 is the excitation wavelength, 488 nm. Similarly, the emitted light, with wavelength $\lambda_2 = 543.6$ nm, suffers scattering and absorption before reaching the objective towards the detector. After reflection, scattering and absorption, the luminescence intensity will be proportional to

$$I_{\text{lumin}} \propto I_0 \cdot 10^{-OD(\lambda_1)} \cdot 10^{-OD(\lambda_2)} \quad [9]$$

where we have assumed that the proportion of light reflected at the incident surface is constant, independent of the sample oxidation state. Both optical densities are proportional to $P_{O_2}^{1/4}$, and therefore a functional dependence such as

$$I_{\text{lumin}} \propto 10^{-b \cdot P_{O_2}^{1/4}} \quad [10]$$

is expected. To better fit to the experimental data, a constant independent term has been added. The continuous line in Fig. 9 is a fit to the data with the expression

$$\frac{I_{\text{lumin}}}{I_{H_2}} = a + (1 - a) \cdot 10^{-b \cdot P_{O_2}^{1/4}} \quad [11]$$

which gives $a = 0.124 \pm 0.014$ and $b = 0.41 \pm 0.03 \text{ bar}^{-1/4}$, with $R = 0.9964$ and P_{O_2} given in bar. Figures after \pm are standard errors. This rough approximation cannot explain the extra term needed to fit the data. b has to be compared with the known values of extinction coefficients. From the reflectance spectra (Figs. 7 or S15) of the sample annealed in Ar (low absorption), one can estimate OD (λ_1)/OD (λ_2) = 2.5. Then one can split the total OD (λ_1) + OD (λ_2) = $b \cdot P_{O_2}^{1/4}$ between both wavelengths. Let us take P_{O_2} as 0.21 bar. Then OD (λ_1) + OD (λ_2) = 0.28, and OD (λ_1) = 0.20. From the single crystal optical absorption spectra we can estimate the absorption coefficient as 3.4 cm^{-1} at 488 nm for 3Tb-YSZ. With this value, one can estimate the path-length the light has travelled in the sample in the luminescence experiment as

$$d = \frac{OD(\lambda_1)}{0.434\alpha(\lambda_1)} = 1.4 \text{ mm}$$

If we force to $a = 1$ in the fitting, b decreases to 0.31 and the estimate for d goes to 1.1 mm. This estimate for d is near to the one estimated in the reflectance experiments, although somewhat smaller as expected by the different optical arrangement. The actual distance that the light has travelled into the sample would be much

smaller than 1.1 mm due to scattering. For example, in dense Al_2O_3 -YSZ-YAG micro-composites produced by controlled solidification of eutectics, Mesa et al.⁵⁰ estimated 5 times longer path-length than sample thickness. A better knowledge of the light scattering in these ceramic pellets, which contain tiny residual porosity, is needed to know the real volume that participates in the experiment. Based on the present results, the depth of sample explored by the backscattering luminescence experiments might be of the order of 100 μm .

It is relevant to note that in the range from 10^{-4} to 100 bar, there is an almost linear relationship between luminescence intensity and $P_{\text{O}_2}^{1/4}$ that can be used to monitor the oxygen activity in these YSZ electrolytes.

Conclusions

Pr and Tb dissolve into the YSZ lattice mainly as $3+$ ions, with less than 1% in a higher oxidation state when the samples are equilibrated in air at atmospheric pressure. The high optical activity of these $4+$ ions provides measurable optical signals (absorption coefficient, reflectance and luminescence) that correlate with the oxygen activity. The experiments show that terbium is better suited for quantification than praseodymium as concentration quenching and superposition of luminescence bands with the one of interest are absent in the first case. The Tb^{4+} absorbance is proportional to $P_{\text{O}_2}^{1/4}$, as expected for an ion having trapped one hole. In the backscattering geometry used in the experiments, a relationship between the luminescence intensity and P_{O_2} has been found, that is consistent with the trapping model and can be used to quantify P_{O_2} (oxygen activity) in the range from 10^{-4} to 10^2 bar. This range is relevant to investigate the oxygen activity near to the oxygen electrode in solid oxide cells, mainly when operated as electrolyzers.

Acknowledgments

This work was financially supported by grant RTI2018-098944-J-I00 funded by MCIN/AEI/ 10.13039/501100011033 and by "ERDF A way of making Europe" and Grant RYC2018-025553-I funded by MCIN/AEI/ 10.13039/501100011033 and by "ESF Investing in your future." The Departamento de Ciencia, Universidad y Sociedad del Conocimiento del Gobierno de Aragón is also acknowledged for the financial support to the Research Group T02 20R. Adrián Robles-Fernández thanks for the grant BES-2016-078508 funded by MCIN/AEI/ 10.13039/501100011033 and by "ESF Investing in your future." Authors would like to acknowledge also the Servicio General de Apoyo a la Investigación SAI, Universidad de Zaragoza.

ORCID

Adrián Robles-Fernández <https://orcid.org/0000-0002-2483-3264>
 Alodia Orera <https://orcid.org/0000-0001-8751-0983>
 José I. Peña <https://orcid.org/0000-0003-2242-6822>
 Rosa I. Merino <https://orcid.org/0000-0003-0747-405X>

References

- A. Orera and P. R. Slater, "New chemical systems for solid oxide fuel cells." *Chem. Mater.*, **22**, 675 (2010).
- M. A. Laguna-Bercero, "Recent advances in high temperature electrolysis using solid oxide fuel cells: A review." *J. Power Sources*, **203**, 4 (2012).
- K. Chen, "Materials degradation of solid oxide electrolysis cells." *J. Electrochem. Soc.*, **163**, F3070 (2016).
- Y. Wang, W. Li, L. Ma, W. Li, and X. Liu, "Degradation of solid oxide electrolysis cells: phenomena, mechanisms and emerging mitigation strategies- a review." *J. Mat. Sci. Tech.*, **55**, 35 (2020).
- R. Knibbe, M. L. Traulsen, A. Hauch, S. D. Ebbesen, and M. Mogensen, "Solid oxide electrolysis cells: degradation at high current densities." *J. Electrochem. Soc.*, **157**, B1209 (2010).
- M. A. Laguna-Bercero, R. Campana, A. Larrea, J. A. Kilner, and V. M. Orera, "Electrolyte degradation in anode supported microtubular yttria stabilized zirconia-based solid oxide steam electrolysis cells at high voltages of operation." *J. Power Sources*, **196**, 8942 (2011).
- C. Graves, S. D. Ebbesen, S. H. Jensen, S. B. Simonsen, and M. B. Mogensen, "Eliminating degradation in solid oxide electrochemical cells by reversible operation." *Nat. Mat.*, **14**, 239 (2015).
- B. K. Park, Q. Zhang, P. W. Voorhees, and S. A. Barnett, "Conditions for stable operation of solid oxide electrolysis cells: oxygen electrode effects." *Energy Environ. Sci.*, **12**, 3053 (2019).
- A. V. Virkar, "Mechanism of oxygen electrode delamination in solid electrolyzer cells." *Int. J. Hydrog. Energy*, **35**, 9527 (2010).
- V. M. Orera, R. I. Merino, and F. Peña, " Ce^{3+} - Ce^{4+} conversion in ceria-doped zirconia single crystals induced by oxido-reduction treatments." *Solid State Ionics*, **72**, 224 (1994).
- R. I. Merino, N. Nicoloso, and J. Maier, "Nature of electronic defects in Yttria-stabilized Zirconia and their influence in Oxygen diffusion." *British Ceramic Proceedings 56: Ceramic Oxygen Ion Conductors*, 43 (1996).
- N. Nicoloso, R. I. Merino, H. Yugami, and J. Maier, "Diffusion of oxygen through YSZ in the presence of redox-active impurities." *Proceedings of the First International Symposium on Ceramic Membranes* (The Electrochemical Society, Pennington, NJ) The Electrochemical Society Proceedings, 95-24, 106 (1997).
- K. Sasaki and J. Maier, "In situ EPR studies of chemical diffusion in oxides." *Phys. Chem. Chem. Phys.*, **2**, 3055 (2000).
- K. Sasaki and J. Maier, "Reanalysis of defect equilibria and transport parameters in Y_2O_3 -stabilized ZrO_2 using EPR and optical relaxation." *Solid State Ion.*, **134**, 303 (2000).
- V. M. Orera and M. A. Laguna, "Micro-spectroscopic study of the degradation of scandia and ceria stabilized zirconia electrolytes in solid oxide electrolysis cells." *Int. J. Hydrogen Energy*, **36**, 13051 (2011).
- A. Mineshige, T. Taji, Y. Muroi, M. Kobune, S. Fujii, N. Nishi, M. Inaba, and Z. Ogumi, "Oxygen chemical potential variation in ceria-based solid oxide fuel cells determined by Raman spectroscopy." *Solid State Ion.*, **135**, 481 (2000).
- M. B. Pomfret, J. C. Owrutsky, and R. A. Walker, "High temperature Raman spectroscopy of solid oxide fuel cell materials and processes." *J. Phys. Chem. B-Letters*, **110**, 17305 (2006).
- E. Brightman, R. Maher, G. J. Offer, V. Duboviks, C. Heck, L. F. Cohen, and N. P. Brandon, "Designing a miniaturized heated stage for in situ optical measurements on solid oxide fuel cell electrode surfaces, and probing the oxidation of solid oxide fuel cell anodes using in situ Raman spectroscopy." *Rev. Sci. Instr.*, **83**, 053707 (2012).
- D. A. Agarkov, I. N. Burmistrov, F. M. Tsybrov, I. I. Tartakovskii, V. V. Kharton, S. I. Bredikhin, and V. V. Kveder, "Analysis of interfacial processes at the SOFC electrodes by in situ raman spectroscopy." *ECS Trans.*, **68**, 2093 (2015).
- T. Matsui, K. Eguchi, T. Furukawa, T. Okanishi, H. Muroyama, and K. Eguchi, "In operando Raman spectroscopy study of oxygen chemical potential change in Ni-SDC cermet anode for solid oxide fuel cells." *J. Electrochem. Soc.*, **163**, F1146 (2016).
- F. Iguchi, S. Onuki, M. Shimizu, T. Kawada, and H. Yugami, "Application of in situ Raman scattering spectroscopy for stress condition measurement in solid oxide fuel cells." *J. Ceram. Soc. Japan*, **125**, 213 (2017).
- M. D. Chambers and D. R. Clarke, "High temperature luminescence and lifetime thermometry." *Annu. Rev. Mater. Res.*, **39**, 325 (2009).
- X. Zhou, S. Jiang, G. Xiang, S. B. Luo, L. Li, and X. J. Zhou, "Tunable emission color of $\text{Li}_2\text{SrSiO}_4:\text{Tb}^{3+}$ due to cross-relaxation process and optical thermometry investigation." *J. Am. Ceram. Soc.*, **101**, 3076 (2018).
- T. H. Etsell and S. N. Flengas, "The electrical properties of solid oxide electrolytes." *Chem. Rev.*, **70**, 339 (1970).
- E. R. Andrievskaya, "Phase equilibria in the refractory oxide systems of zirconia, hafnia and yttria with rare-earth oxides." *J. Europ. Ceram. Soc.*, **28**, 2363 (2008).
- D. H. Prasad, S. Y. Park, H. I. Ji, H. R. Kim, J. W. Son, B. K. Kim, H. W. Lee, and J. H. Lee, "Structural characterization and catalytic activity of $\text{Ce}_{0.65}\text{Zr}_{0.25}\text{RE}_{0.1}\text{O}_{2-\delta}$ nanocrystalline powders synthesized by the glycine-nitrate process." *J. Phys. Chem. C*, **116**, 3467 (2012).
- A. Doménech, N. Montoya, and J. Alarcón, "Electrochemical characterization of praseodymium centers in $\text{Pr}_x\text{Zr}_{1-x}\text{O}_2$ zirconias using electrocatalysis." *J. Solid State Electrochem.*, **16**, 963 (2012).
- M. R. N. Soares, C. Nico, J. Rodrigues, M. Peres, M. J. Soares, A. J. S. Fernandes, F. M. Costa, and T. Monteiro, "Bright room-temperature green luminescence from $\text{YSZ}:\text{Tb}^{3+}$." *Mater. Lett.*, **65**, 1979 (2011).
- P. Riello, S. Bucella, D. Cristofori, A. Benedetti, R. Polloni, E. Trave, and P. Mazzoldi, "Effect of the microstructure on concentration quenching in heavily doped Tb_2O_3 - ZrO_2 nanoparticles embedded in silica." *Chem. Phys. Letters*, **431**, 326 (2006).
- B. Savoini, J. E. Muñoz-Santiuste, and R. González, "Optical characterization of Pr 31-doped yttria-stabilized zirconia single crystals." *Phys. Rev. B*, **56**, 5856 (1997).
- J. E. Muñoz-Santiuste, B. Savoini, and R. González, "Pr³⁺ centers in YSZ single crystals." *J. All. Comp.*, **323-324**, 768 (2001).
- M. R. N. Soares, C. Nico, J. Rodrigues, M. Peres, M. J. Soares, A. J. S. Fernandes, F. M. Costa, and T. Monteiro, "Red and infrared luminescence from tetragonal $\text{YSZ}:\text{Pr}^{3+}$ single crystal fibres grown by LFZ." *Opt. Mat.*, **34**, 27 (2011).
- B. M. Moshaghoun, J. I. Peña, and R. I. Merino, "Can Y_2O_3 - MgO eutectics be new promising structural and optical ceramics?" *Acta Mater.*, **216**, 117139 (2021).
- M. Yashima, S. Sasaki, M. Kakhiana, Y. Yamaguchi, H. Arashi, and M. Yoshimura, "Oxygen-induced structural change of the tetragonal phase around the tetragonal-cubic phase boundary in ZrO_2 - $\text{YO}_{1.5}$ solid solutions." *Acta Crystallogr.*, **B50**, 663 (1994).

35. Y. Hemberger, N. Wichtner, C. Berthold, and K. G. Nickel, "Quantification of yttria in stabilized zirconia by raman spectroscopy." *Int. J. Appl. Ceram. Technol.*, **13**, 116 (2016).
36. W. T. Carnall, P. R. Fields, and B. G. Wybourne, "Spectral intensities of the trivalent lanthanides and actinides in solution. I." *J. Chem. Phys.*, **42**, 3797 (1965).
37. H. E. Hoefdraad, "Charge-transfer spectra of tetravalent lanthanide ions in oxides." *J. Inorg. Nuc. Chem.*, **37**, 1917 (1975).
38. G. H. Diecke and H. M. Crosswhite, "The spectra of the doubly and triply ionized rare earths." *Appl. Opt.*, **2**, 675 (1963).
39. L. Sojka, Z. Tang, D. Funiss, H. Sakr, Y. Fang, E. Beres-Pawlik, T. M. Benson, A. B. Seddon, and S. Sujecki, "Mid-infrared emission in Tb³⁺ doped selenide glass fiber." *J. Opt. Soc. Am. B*, **34**, A70 (2017).
40. W. T. Carnall, P. R. Fields, and K. Rajnak, "Spectral intensities of the trivalent lanthanides and actinides in solution II. Pm³⁺, Sm³⁺, Eu³⁺, Gd³⁺, Tb³⁺, Dy³⁺ and Ho³⁺." *J. Chem. Phys.*, **49**, 4412 (1968).
41. N. van Vugt, T. Wigmans, and G. Blasse, "Electron transfer spectra of some tetravalent lanthanide ions in ZrO₂." *J. Inorg. Nucl. Chem.*, **35**, 2601 (1963).
42. R. K. Verma, K. Kumar, and S. B. Rai, "Inter-conversion of Tb³⁺ and Tb⁴⁺ states and its fluorescence properties in MO-Al₂O₃:Tb (M = Mg, Ca, Sr, Ba) phosphor materials." *Solid State Sci.*, **12**, 1146e1151 (2010).
43. E. Zych, P. J. Deren, W. Strek, A. Meijerink, W. Mielcarek, and K. Domagala, "Preparation, X-ray analysis and spectroscopic investigation of nanostructured Lu₂O₃: Tb." *J. Alloys Compd.*, **323–324**, 8 (2001).
44. H. Dornauf and J. Heber, "Concentration-dependent fluorescence-quenching in La_{1-x}Pr_xP₅O₁₄." *J. Lumin.*, **22**, 1 (1980).
45. D. N. Wang, S. L. Xu, X. Y. Wang, S. Y. Li, X. Hong, B. A. Goodman, and W. Deng, "Crystal growth, structure and optical properties of Pr³⁺ doped yttria-stabilized zirconia single crystals." *Chin. Phys. B*, **30**, 078103 (2021).
46. J. E. Muñoz-Santiuste, B. Savoini, and R. González, "Pr³⁺ centers in YSZ single crystals." *J. Alloys and Compounds*, **323–324**, 768 (2001).
47. T. Hayakawa, N. Kamata, and K. Yamad, "Visible emission characteristics in Tb³⁺-doped fluorescent glasses under selective excitation." *J. Lum.*, **68**, 179 (1996).
48. N. Duhamel-Henry, J. L. Adam, B. Jacquier, and C. Linares, "Photoluminescence of new fluorophosphates glasses containing a high concentration of terbium (II) ion." *Opt. Mat.*, **5**, 197 (1996).
49. J. Maier, *Physical Chemistry of Ionic Materials: Ions and Electrons in Solids*. (Wiley, New York, NY) (2004).
50. M. C. Mesa, P. B. Oliete, R. I. Merino, and V. M. Orera, "Optical absorption and selective thermal emission in directionally solidified Al₂O₃-Er₃Al₅O₁₂ and Al₂O₃-Er₃Al₅O₁₂-ZrO₂ eutectics." *J. Eur. Ceram. Soc.*, **33**, 2587 (2013).